

**Notice of References Cited**

Application/Control No.

10/775,103

Applicant(s)/Patent Under  
Reexamination  
KAWAHARA ET AL.

Examiner

Ari M. Diacou

Art Unit

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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	C	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Freund, Wilson. Statistical Methods 2 <sup>nd</sup> Ed. Academic Press. San Diego, CA. pp. 236-240. Pub. Date: 12/23/2002.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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